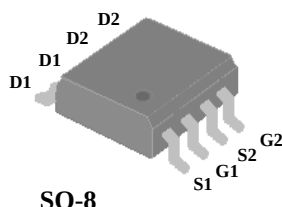


- ▼ Simple Drive Requirement
- ▼ Low Gate Charge
- ▼ Fast Switching Performance
- ▼ RoHS Compliant & Halogen-Free

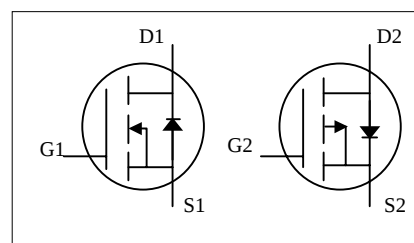


|      |              |               |
|------|--------------|---------------|
| N-CH | $BV_{DSS}$   | 100V          |
|      | $R_{DS(ON)}$ | 150m $\Omega$ |
|      | $I_D$        | 2.5A          |
| P-CH | $BV_{DSS}$   | -100V         |
|      | $R_{DS(ON)}$ | 160m $\Omega$ |
|      | $I_D$        | -2.5A         |

## Description

XP5521 series are innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The SO-8 package is widely preferred for all commercial-industrial surface mount applications using infrared reflow technique and suited for voltage conversion or switch applications.



## Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

| Symbol                     | Parameter                            | Rating     |           | Units            |
|----------------------------|--------------------------------------|------------|-----------|------------------|
|                            |                                      | N-channel  | P-channel |                  |
| $V_{DS}$                   | Drain-Source Voltage                 | 100        | -100      | V                |
| $V_{GS}$                   | Gate-Source Voltage                  | $\pm 20$   | $\pm 20$  | V                |
| $I_D@T_A=25^\circ\text{C}$ | Drain Current, $V_{GS} @ 10V^3$      | 2.5        | -2.5      | A                |
| $I_D@T_A=70^\circ\text{C}$ | Drain Current, $V_{GS} @ 10V^3$      | 2.0        | -2.0      | A                |
| $I_{DM}$                   | Pulsed Drain Current <sup>1</sup>    | 10         | -10       | A                |
| $P_D@T_A=25^\circ\text{C}$ | Total Power Dissipation              | 2          |           | W                |
| $T_{STG}$                  | Storage Temperature Range            | -55 to 150 |           | $^\circ\text{C}$ |
| $T_J$                      | Operating Junction Temperature Range | -55 to 150 |           | $^\circ\text{C}$ |

## Thermal Data

| Symbol | Parameter                                                 | Value | Unit                      |
|--------|-----------------------------------------------------------|-------|---------------------------|
| Rthj-a | Maximum Thermal Resistance, Junction-ambient <sup>3</sup> | 62.5  | $^\circ\text{C}/\text{W}$ |

**N-CH Electrical Characteristics@T<sub>j</sub>=25°C(unless otherwise specified)**

| Symbol              | Parameter                                      | Test Conditions                                          | Min. | Typ. | Max. | Units |
|---------------------|------------------------------------------------|----------------------------------------------------------|------|------|------|-------|
| BV <sub>DSS</sub>   | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V, I <sub>D</sub> =250uA               | 100  | -    | -    | V     |
| R <sub>DS(ON)</sub> | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =10V, I <sub>D</sub> =2A                 | -    | 120  | 150  | mΩ    |
|                     |                                                | V <sub>GS</sub> =5V, I <sub>D</sub> =1A                  | -    | 145  | 250  | mΩ    |
| V <sub>GS(th)</sub> | Gate Threshold Voltage                         | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA | 1    | 1.4  | 3    | V     |
| g <sub>fs</sub>     | Forward Transconductance                       | V <sub>DS</sub> =10V, I <sub>D</sub> =2A                 | -    | 3.3  | -    | S     |
| I <sub>DSS</sub>    | Drain-Source Leakage Current                   | V <sub>DS</sub> =80V, V <sub>GS</sub> =0V                | -    | -    | 10   | uA    |
| I <sub>GSS</sub>    | Gate-Source Leakage                            | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V               | -    | -    | ±100 | nA    |
| Q <sub>g</sub>      | Total Gate Charge                              | I <sub>D</sub> =2A                                       | -    | 6    | 10   | nC    |
| Q <sub>gs</sub>     | Gate-Source Charge                             | V <sub>DS</sub> =50V                                     | -    | 1.5  | -    | nC    |
| Q <sub>gd</sub>     | Gate-Drain ("Miller") Charge                   | V <sub>GS</sub> =4.5V                                    | -    | 3    | -    | nC    |
| t <sub>d(on)</sub>  | Turn-on Delay Time                             | V <sub>DS</sub> =50V                                     | -    | 4.5  | -    | ns    |
| t <sub>r</sub>      | Rise Time                                      | I <sub>D</sub> =1A                                       | -    | 6.5  | -    | ns    |
| t <sub>d(off)</sub> | Turn-off Delay Time                            | R <sub>G</sub> =3.3 Ω                                    | -    | 16   | -    | ns    |
| t <sub>f</sub>      | Fall Time                                      | V <sub>GS</sub> =10V                                     | -    | 5.5  | -    | ns    |
| C <sub>iss</sub>    | Input Capacitance                              | V <sub>GS</sub> =0V                                      | -    | 420  | 670  | pF    |
| C <sub>oss</sub>    | Output Capacitance                             | V <sub>DS</sub> =15V                                     | -    | 70   | -    | pF    |
| C <sub>rss</sub>    | Reverse Transfer Capacitance                   | f=1.0MHz                                                 | -    | 50   | -    | pF    |

**Source-Drain Diode**

| Symbol          | Parameter                       | Test Conditions                           | Min. | Typ. | Max. | Units |
|-----------------|---------------------------------|-------------------------------------------|------|------|------|-------|
| V <sub>SD</sub> | Forward On Voltage <sup>2</sup> | I <sub>S</sub> =1.5A, V <sub>GS</sub> =0V | -    | -    | 1.3  | V     |
| t <sub>rr</sub> | Reverse Recovery Time           | I <sub>S</sub> =2A, V <sub>GS</sub> =0V   | -    | 35   | -    | ns    |
| Q <sub>rr</sub> | Reverse Recovery Charge         | dI/dt=100A/μs                             | -    | 50   | -    | nC    |

**P-CH Electrical Characteristics@T<sub>j</sub>=25°C(unless otherwise specified)**

| Symbol              | Parameter                                      | Test Conditions                                           | Min. | Typ. | Max. | Units |
|---------------------|------------------------------------------------|-----------------------------------------------------------|------|------|------|-------|
| BV <sub>DSS</sub>   | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA               | -100 | -    | -    | V     |
| R <sub>DS(ON)</sub> | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =-10V, I <sub>D</sub> =-2A                | -    | 125  | 160  | mΩ    |
|                     |                                                | V <sub>GS</sub> =-5V, I <sub>D</sub> =-1A                 | -    | 145  | 250  | mΩ    |
| V <sub>GS(th)</sub> | Gate Threshold Voltage                         | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA | -1   | -2   | -3   | V     |
| g <sub>fs</sub>     | Forward Transconductance                       | V <sub>DS</sub> =-10V, I <sub>D</sub> =-2A                | -    | 8    | -    | S     |
| I <sub>DSS</sub>    | Drain-Source Leakage Current                   | V <sub>DS</sub> =-80V, V <sub>GS</sub> =0V                | -    | -    | -10  | uA    |
| I <sub>GSS</sub>    | Gate-Source Leakage                            | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                | -    | -    | ±100 | nA    |
| Q <sub>g</sub>      | Total Gate Charge                              | I <sub>D</sub> =-2A                                       | -    | 14   | 22.5 | nC    |
| Q <sub>gs</sub>     | Gate-Source Charge                             | V <sub>DS</sub> =-50V                                     | -    | 4    | -    | nC    |
| Q <sub>gd</sub>     | Gate-Drain ("Miller") Charge                   | V <sub>GS</sub> =-4.5V                                    | -    | 7    | -    | nC    |
| t <sub>d(on)</sub>  | Turn-on Delay Time                             | V <sub>DS</sub> =-50V                                     | -    | 10   | -    | ns    |
| t <sub>r</sub>      | Rise Time                                      | I <sub>D</sub> =-1A                                       | -    | 5    | -    | ns    |
| t <sub>d(off)</sub> | Turn-off Delay Time                            | R <sub>G</sub> =3.3Ω                                      | -    | 50   | -    | ns    |
| t <sub>f</sub>      | Fall Time                                      | V <sub>GS</sub> =-10V                                     | -    | 21   | -    | ns    |
| C <sub>iss</sub>    | Input Capacitance                              | V <sub>GS</sub> =0V                                       | -    | 1400 | 2240 | pF    |
| C <sub>oss</sub>    | Output Capacitance                             | V <sub>DS</sub> =-15V                                     | -    | 135  | -    | pF    |
| C <sub>rss</sub>    | Reverse Transfer Capacitance                   | f=1.0MHz                                                  | -    | 90   | -    | pF    |

**Source-Drain Diode**

| Symbol          | Parameter                       | Test Conditions                            | Min. | Typ. | Max. | Units |
|-----------------|---------------------------------|--------------------------------------------|------|------|------|-------|
| V <sub>SD</sub> | Forward On Voltage <sup>2</sup> | I <sub>S</sub> =-1.5A, V <sub>GS</sub> =0V | -    | -    | -1.3 | V     |
| t <sub>rr</sub> | Reverse Recovery Time           | I <sub>S</sub> =-2A, V <sub>GS</sub> =0V   | -    | 40   | -    | ns    |
| Q <sub>rr</sub> | Reverse Recovery Charge         | di/dt=-100A/μs                             | -    | 80   | -    | nC    |

**Notes:**

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board, t<sub>j</sub>≤10sec ; 135 °C/W when mounted on Min. copper pad.

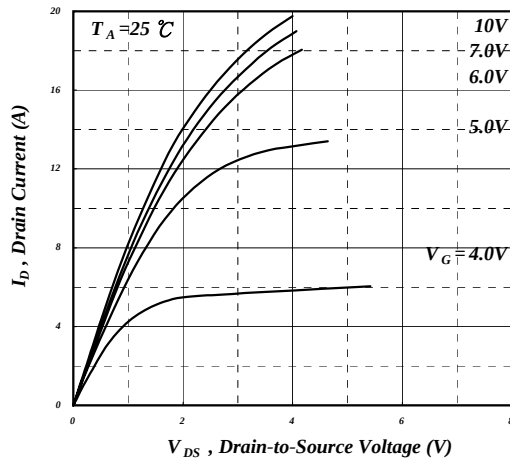
THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

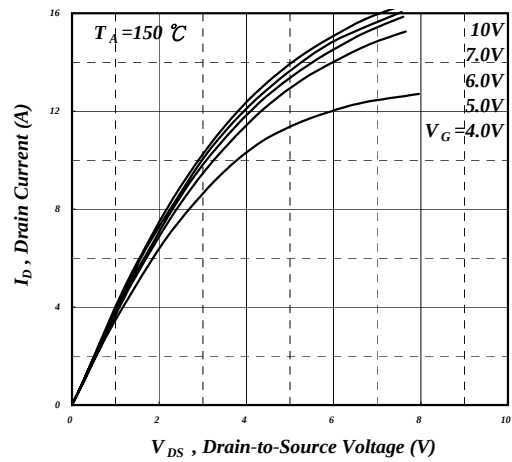
XSEMI DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

XSEMI RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN.

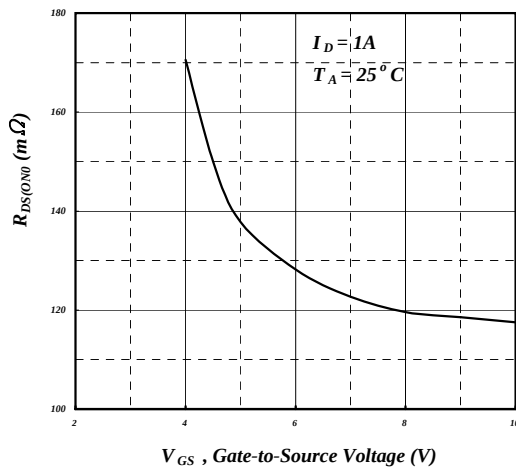
**N-Channel**



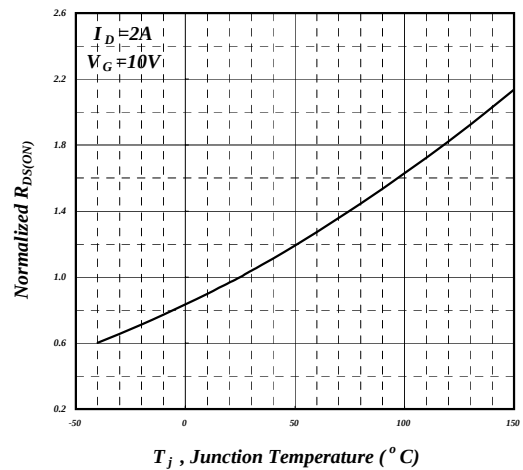
**Fig 1. Typical Output Characteristics**



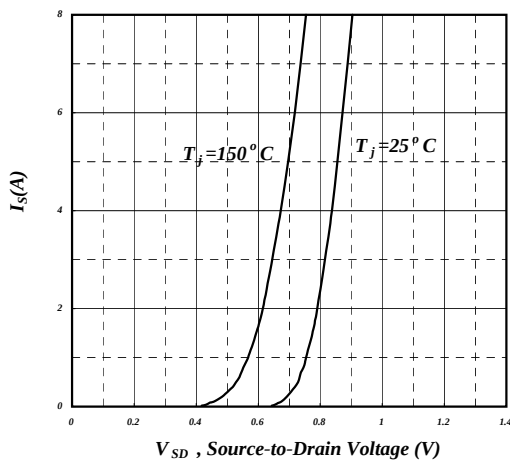
**Fig 2. Typical Output Characteristics**



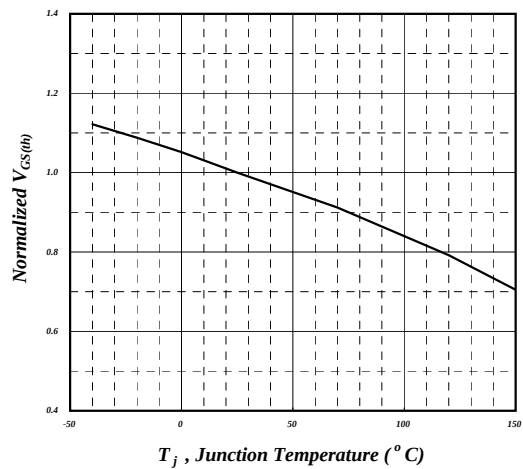
**Fig 3. On-Resistance v.s. Gate Voltage**



**Fig 4. Normalized On-Resistance v.s. Junction Temperature**

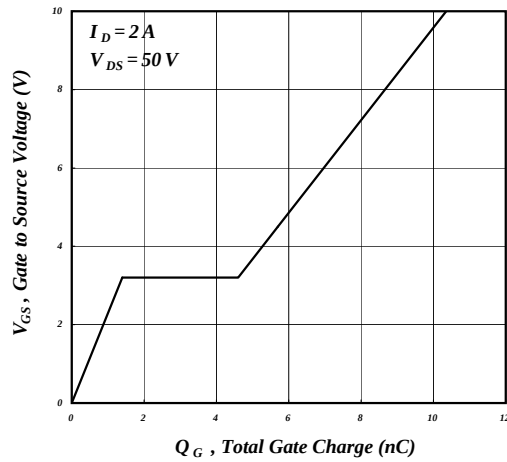


**Fig 5. Forward Characteristic of Reverse Diode**

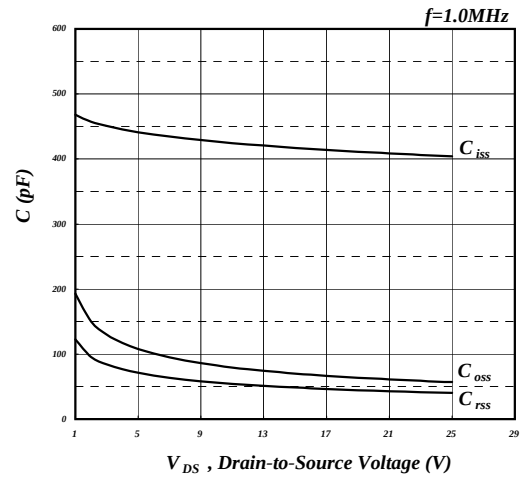


**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**

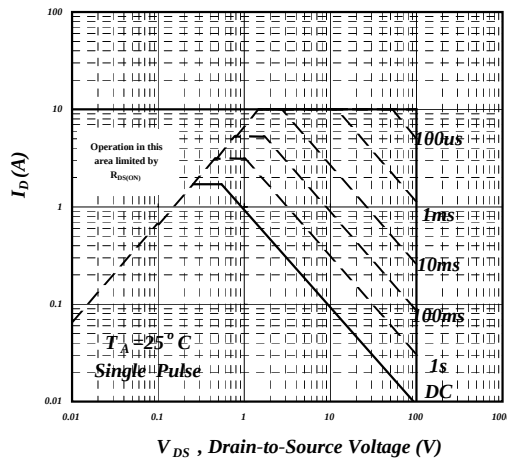
**N-Channel**



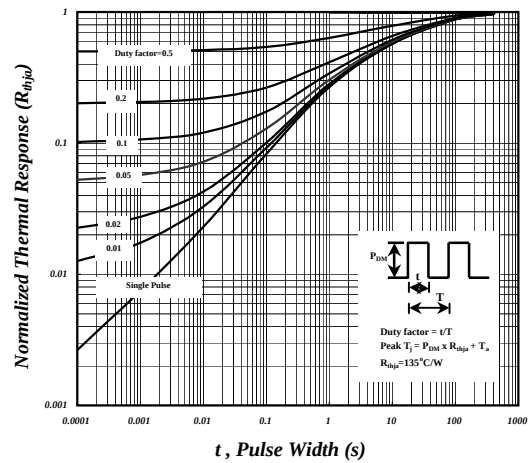
**Fig 7. Gate Charge Characteristics**



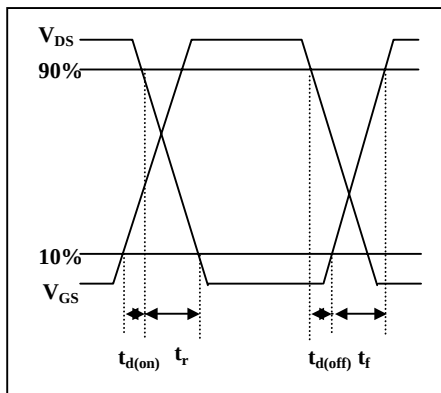
**Fig 8. Typical Capacitance Characteristics**



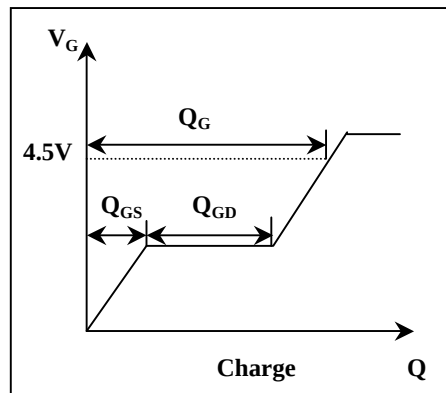
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**

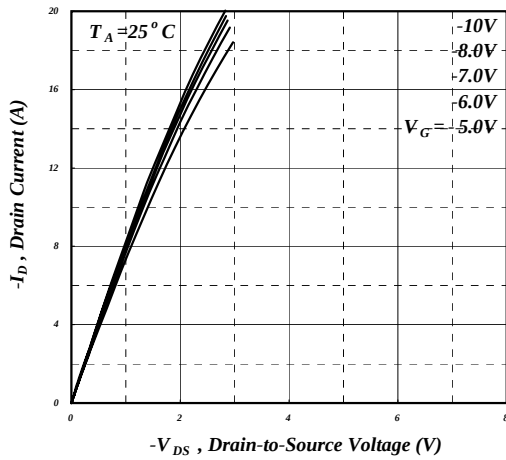


**Fig 11. Switching Time Waveform**

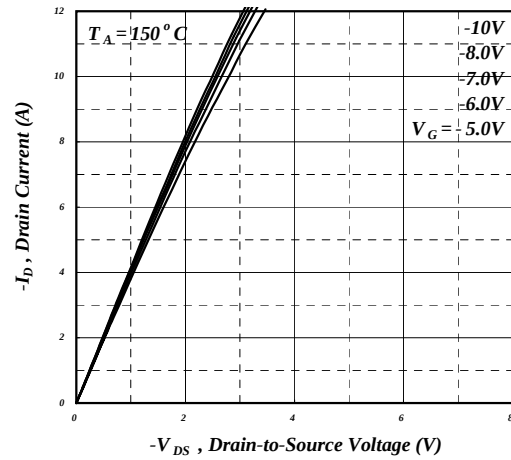


**Fig 12. Gate Charge Waveform**

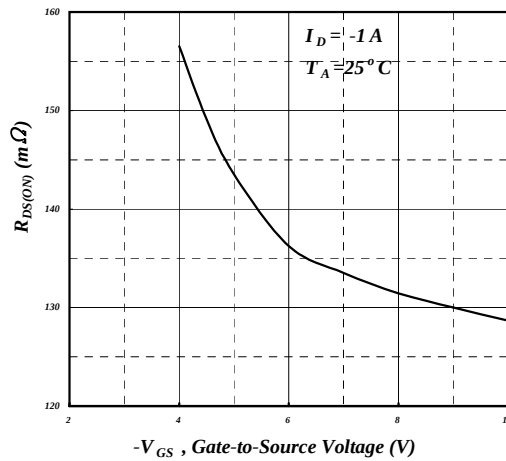
**P-Channel**



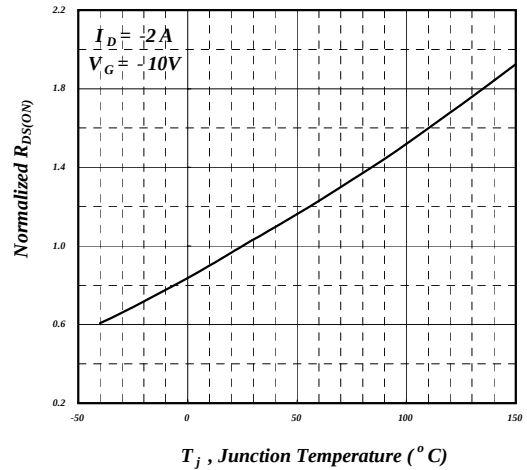
**Fig 1. Typical Output Characteristics**



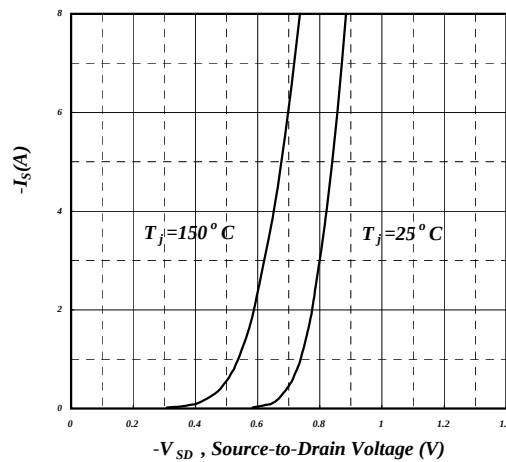
**Fig 2. Typical Output Characteristics**



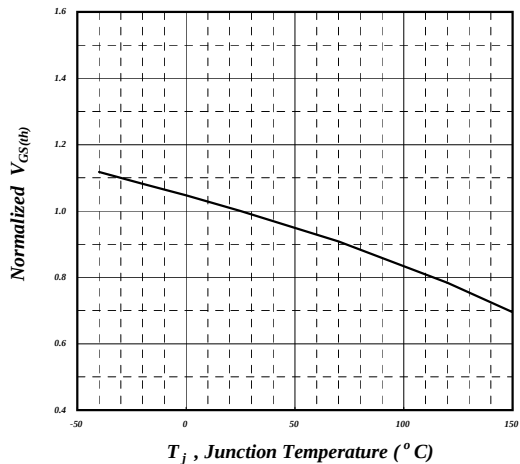
**Fig 3. On-Resistance v.s. Gate Voltage**



**Fig 4. Normalized On-Resistance  
v.s. Junction Temperature**

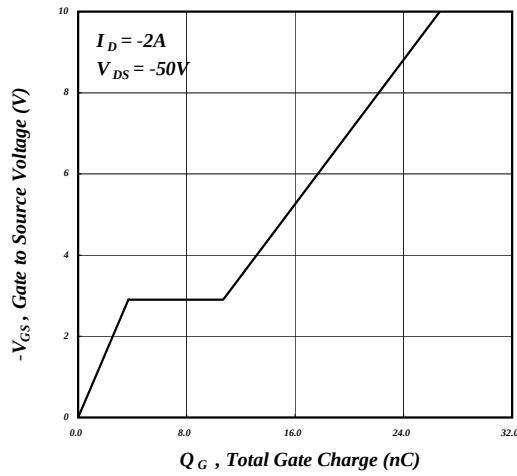


**Fig 5. Forward Characteristic of  
Reverse Diode**

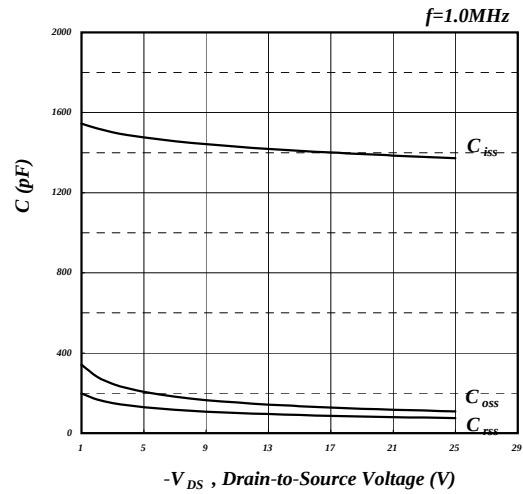


**Fig 6. Gate Threshold Voltage v.s.  
Junction Temperature**

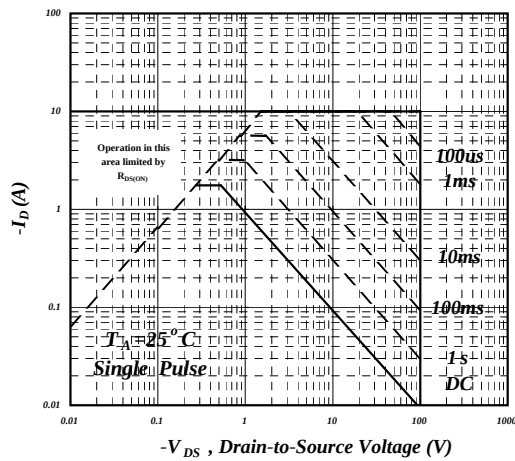
**P-Channel**



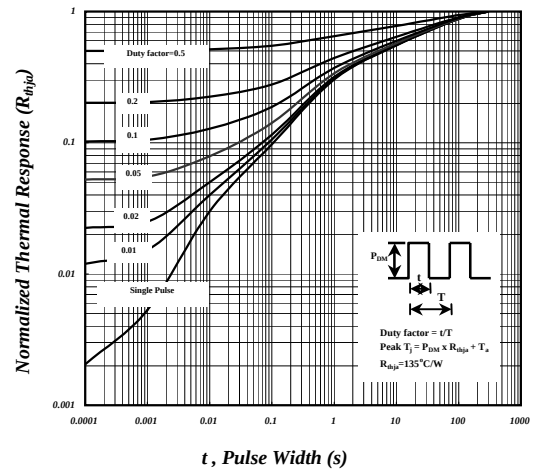
**Fig 7. Gate Charge Characteristics**



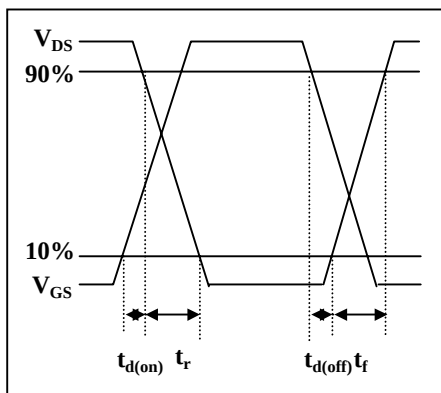
**Fig 8. Typical Capacitance Characteristics**



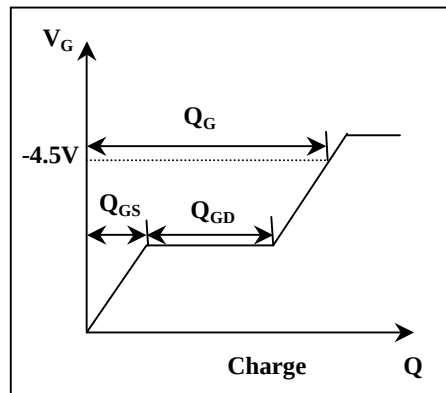
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**

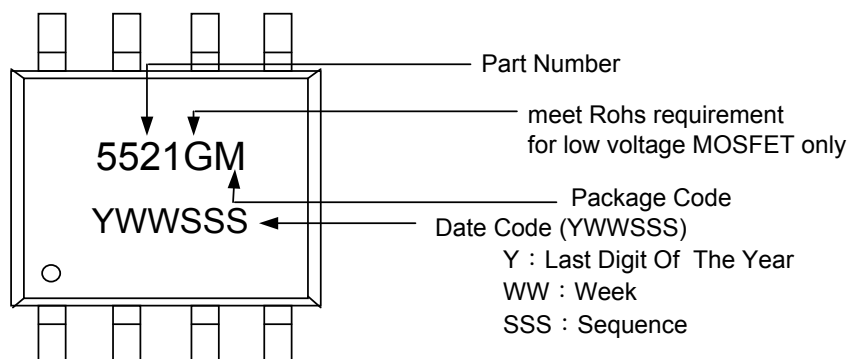


**Fig 11. Switching Time Waveform**

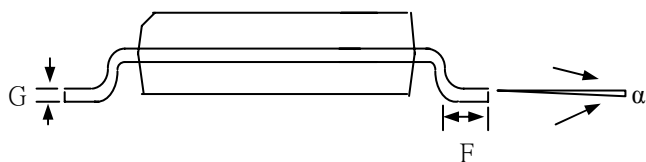
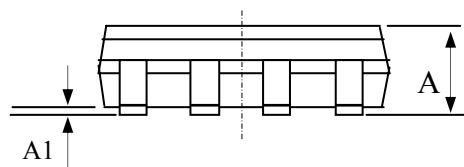
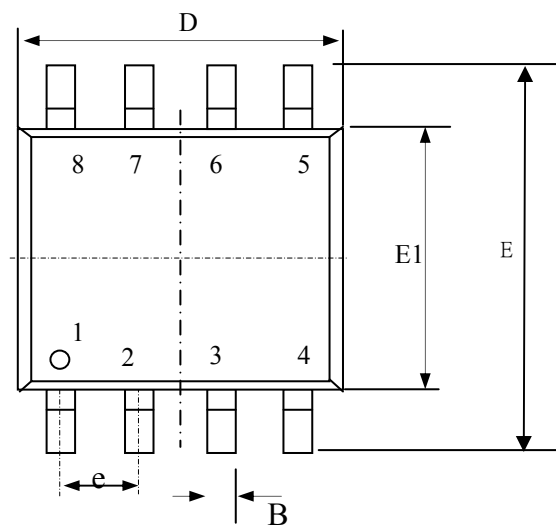


**Fig 12. Gate Charge Waveform**

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**MARKING INFORMATION**

## Package Outline : SO-8



| SYMBOLS  | Millimeters |      |      |
|----------|-------------|------|------|
|          | MIN         | NOM  | MAX  |
| A        | 1.35        | 1.55 | 1.75 |
| A1       | 0.05        | 0.15 | 0.25 |
| B        | 0.30        | 0.41 | 0.51 |
| D        | 4.80        | 5.05 | 5.30 |
| E        | 5.79        | 6.00 | 6.20 |
| E1       | 3.70        | 3.90 | 4.10 |
| e        | 1.27 TYP    |      |      |
| G        | 0.17        | 0.21 | 0.25 |
| F        | 0.38        | 0.83 | 1.27 |
| $\alpha$ | 0°          | 4°   | 8°   |

- 1.All Dimension Are In Millimeters.
- 2.Dimension Does Not Include Mold Protrusions.

**SO-8 FOOTPRINT :**

